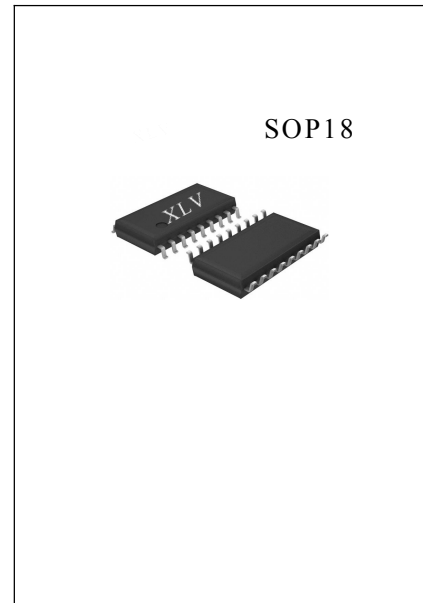


General Description

The eight NPN Darlington connected transistors in this family of arrays are ideally suited for interfacing between low logic level digital circuitry (such as TTL, CMOS or PMOS/NMOS) and the higher current/voltage requirements of lamps, relays, printer hammers or other similar loads for a broad range of computer, industrial, and consumer applications. All devices feature open-collector outputs and free wheeling clamp diodes for transient suppression

The ULN2803 is designed to be compatible with standard TTL families while the ULN2804 is optimized for 6 to 15 volt high level CMOS or PMOS.



Package Information

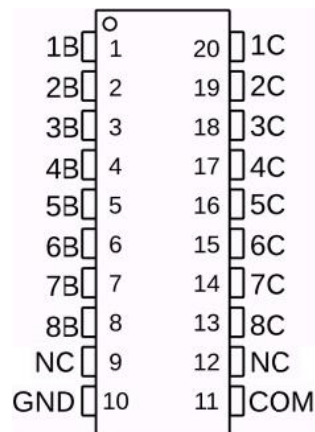
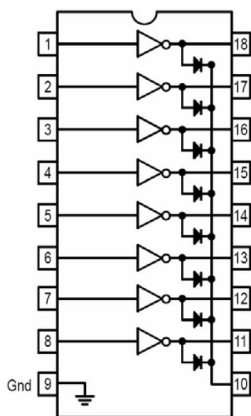
Part NO.	Package Description	Package Marking	Package Option
ULN2803F	SOP18	ULN2803F XLV XX	40/Tube 1500/Reel

XLV: e-mark

ULN2803/ULN2803C/ULN2803F:Part NO.

XX:Lot NO.

Pin Connection



Absolute Maximum Ratings

(T_A=25°C and rating apply to any one device in the package, unless otherwise noted.)

Characteristic		Symbol	Limit	Unit
Output voltage		V _O	50	V
Input voltage		V _I	30	V
Collector current-continuous		I _C	500	mA/ch
Base current-continuous		I _B	25	mA
Clamp diode reverse voltage		V _R	50	V
Clamp diode forward current		I _F	500	mA
Power Dissipation	SOP18	P _D	0.92/1.31(Note)	W
Operating temperature		T _{opr}	-40 ~ +85	°C
Storage temperature		T _{stg}	-55 ~ +150	°C
Junction temperature		T _J	125	°C

- Note: 1. On Glass Epoxy PCB (75 × 114 × 1.6 mm Cu 20%)
 2. R_{θJA} =55°C/W
 3. Do not exceed maximum current limit per driver.

Electrical Characteristics (T_a=25°C, unless otherwise noted)

Characteristic	Symbol	Test condition	Limit			Unit
			Min.	Typ.	Max.	
Output leakage current (Fig.1)	I _{CEx}	V _O =50V, T _A =70°C			100	μA
		V _O =50V, T _A =25°C			50	
Collector-Emitter saturation voltage(Fig.2)	V _{CE(sat)}	I _C =350mA, I _B =500μA		1.1	1.6	V
		I _C =200mA, I _B =350μA		0.95	1.3	
		I _C =100mA, I _B =250μA		0.85	1.1	
Input current-on condition (Fig.4)	I _{I(on)}	V _I =3.85V		1.1	1.35	mA
Input voltage-on condition (Fig.5)	V _{I(on)}	V _{CE} =2.0V, I _C =200mA		1.7	2.4	V
		V _{CE} =2.0V, I _C =250mA		1.75	2.7	
		V _{CE} =2.0V, I _C =300mA		1.8	3.0	
Input current-off Condition (Fig.3)	I _{I(off)}	I _C =500μA, T _A =70°C	50	100		μA
Input capacitance	C _I			15	25	pF
Turn-on delay time (50% E _I to 50% E _O)	t _{on}			0.25	1.0	μs
Turn-off delay time (50% E _I to 50% E _O)	t _{off}			0.25	1.0	μs
Clamp diode leakage Current(V _R =50V)(Fig.6)	I _R	T _A =25°C			50	μA
		T _A =70°C			100	
Clamp diode forward Voltage (Fig.7)	V _F	I _F =350mA		1.5	2.0	V

Test Circuit

Figure 1.

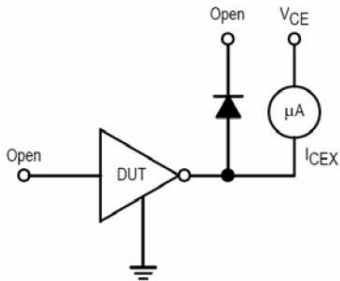


Figure 2.

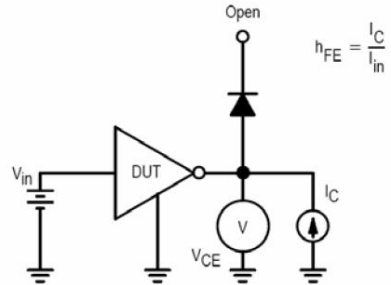


Figure 3.

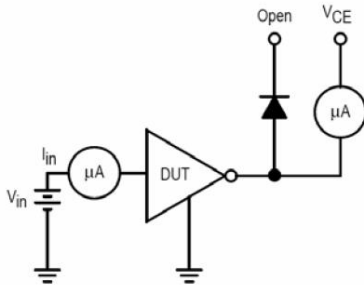


Figure 4.

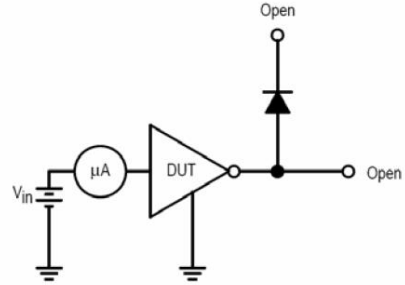


Figure 5.

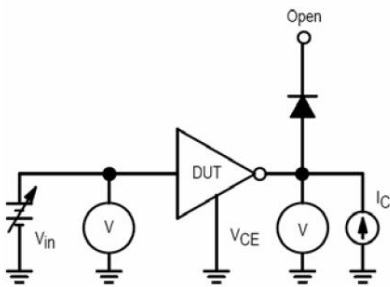


Figure 6.

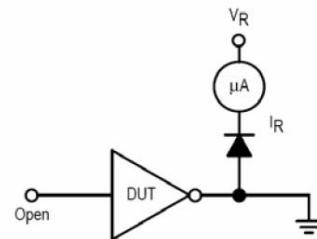
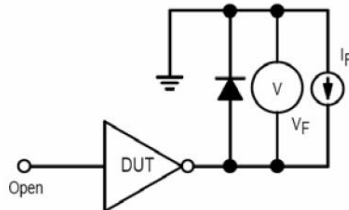
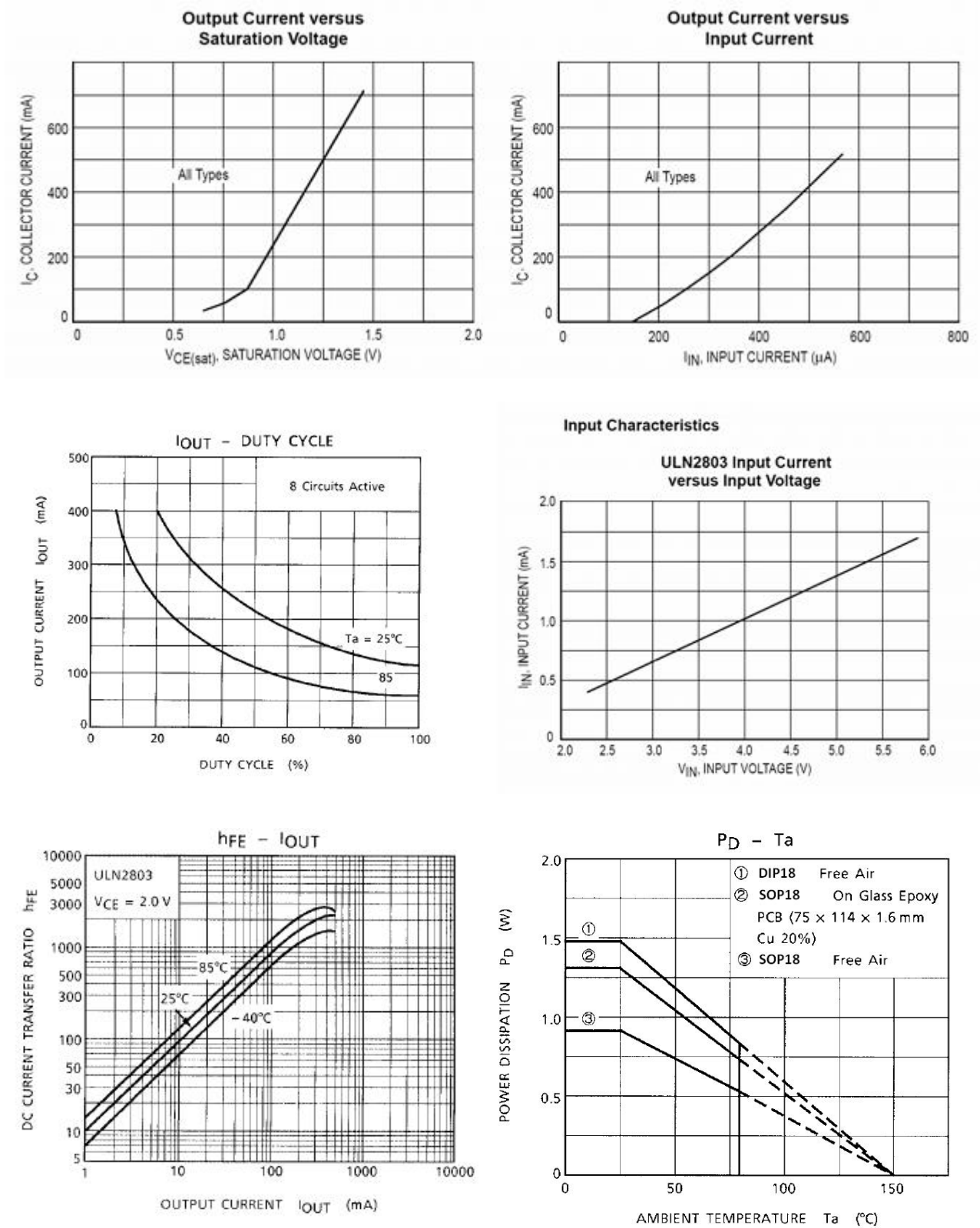
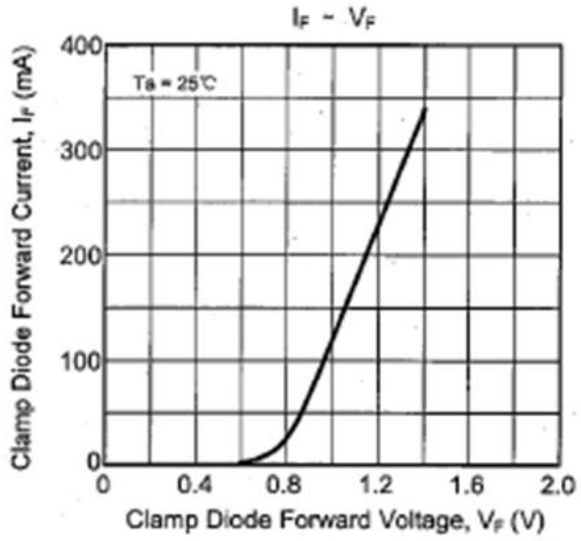


Figure 7.

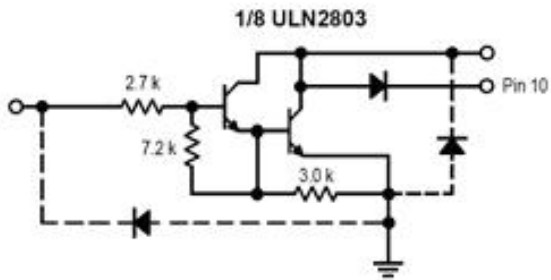


Typical Curve

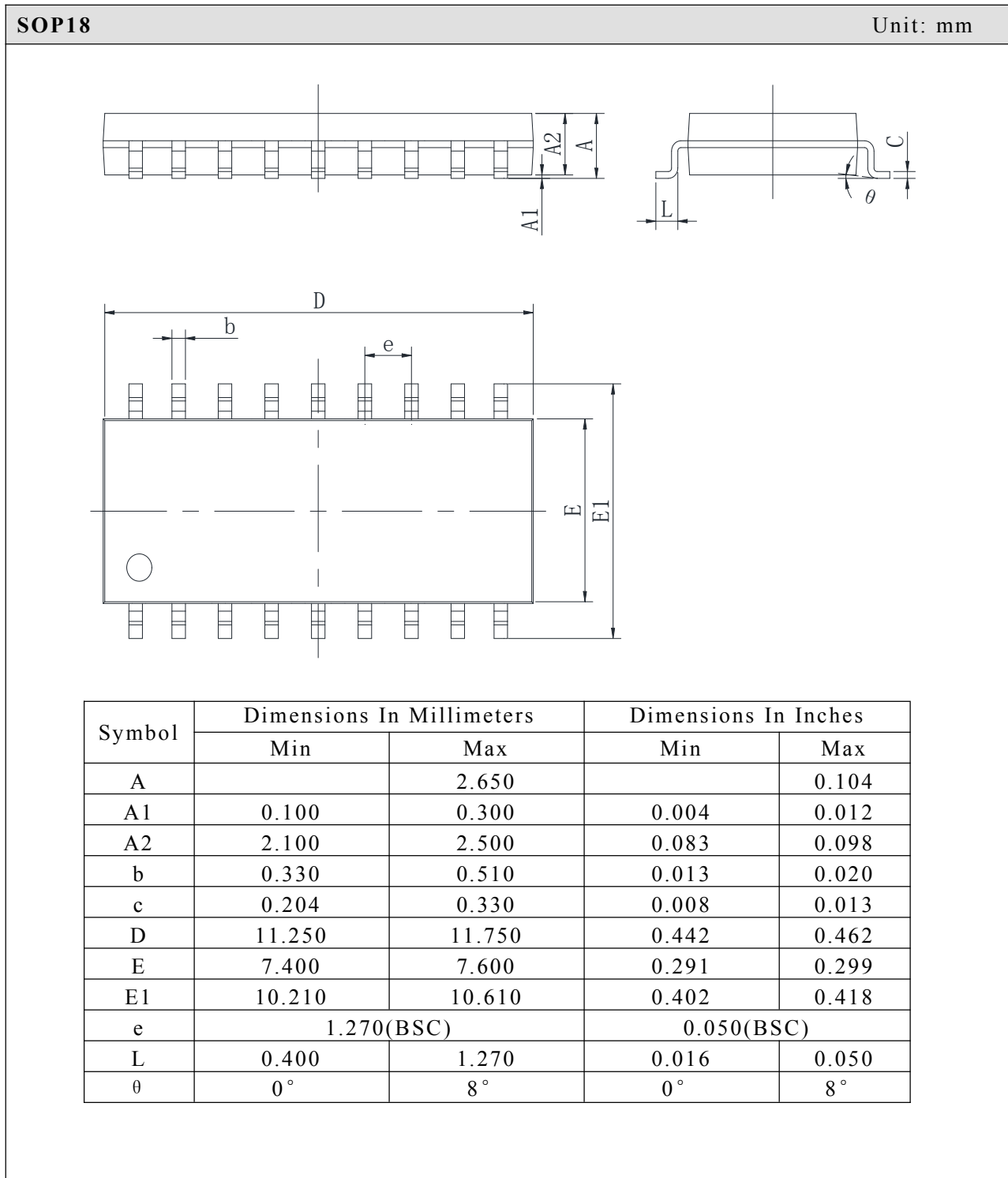




Representative Schematic Diagrams



Outline Dimensions



Statements

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